

Notice of References Cited

Application/Control No.

10/034,326

Applicant(s)/Patent Under

Reexamination

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Examiner

Edna Wong

Art Unit

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Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,514,261	05-1996	Herklotz et al.	205/238
	B	US-5,215,631	06-1993	Westfall, Richard M.	205/351
	C	US-			
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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